## Search Notes



Application/Control No.	Applicant(s)/Patent under
	Reexamination

3751

10/551,444 TANI, YOSHIKAZU
Examiner Art Unit

Huyen Le

SEARCHED					
Class	Subclass	Date	Examiner		
401	172-174	4/30/2009	HL		

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
	-		+	

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
· V	DATE	EXMR		